X-ray absorption spectroscopy

Prof. Hugh H. Harris Department of Chemistry The University of Adelaide hugh.harris@adelaide.edu.au

AOFSRR - synchrotron school – May 30, 2017

Outline

X-ray absorption spectroscopy (XAS)

- 1. EXAFS
- 2. XANES
- 3. Applications

Most slides courtesy – Prof. G. N. George, University of Saskatchewan

Useful Resources

http://www.ixasportal.net/ixas/

http://xafs.org/Tutorials?action=AttachFile&do=get&target=Newvill e_xas_fundamentals.pdf

Levina *et. al*, 2005, Coord Chem Rev, **249**, pp141-160, sections 1 and 2 only

Bending Magnets and Insertion Devices

- maintain the electron beam orbit
- wide emission cone angle
- low brightness still valuable though

- insertion device
- electron beam path
 oscillates in plane of ring
- broad output spectrum (good for spectroscopy as easily tuned)
- incoherent light
- intermediate brightness

- similar to wiggler but gentler undulations
- wavefronts from consecutive bends constructively interfere
- high brightness in narrow λ band – adjust gap (hence mag. field) for different λ •difficult to tune (not as good
- for spectroscopy?)
- •narrow cone coherent!



Bending Magnet



Wiggler



Undulator

X-ray Absorption Spectroscopy



X-ray Absorption Spectroscopy – Basic Physics



(μ here is the absorption coefficient from Beer's Law, i.e. A = μ c I)

X-ray Absorption Spectroscopy – Basic Physics



X-ray absorption spectroscopy is element-specific



K-edge XAS of some first transition elements.

X-ray absorption spectroscopy sees all atoms of one element in a sample!

- Hence the overall XAS signal is the sum of the signals from every atom of the particular element in the beam path
 - XAS gives the average local environment
- Contamination can be a big problem especially where the element of interest is at low concentrations
- Occasionally it is possible to determine structural information for two different sites within a sample – but this is rare

X-rays have high energy and are penetrative

- X-rays penetrate further into a given substance with increasing energy
- Also XAS does not depend upon long range order in a sample (*cf.* XRD) so XAS can cope with samples in ANY phase – e.g. solids, gases, liquids, mixtures etc.
- Heavier elements have higher absorption cross-sections than light elements – so penetration depth (and fluorescence escape depth) must be considered

Choice of X-ray Absorption Edge

Different core levels may be excited to give rise to K-edge and L-edges



Choice of X-ray Absorption Edge



EXAFS: K-edges have best edge jump - best signal to noise
 L-edges have multiple edges - second edge can truncate EXAFS data
 For higher atomic numbers (> 50) L-edges are only edge accessible for EXAFS
 Edge spectra: Different types of edge have different selection rules, therefore different information
 Resolution is better for lower energies

Detection of X-ray Absorption Spectra

- 1. by measuring the transmission of X-rays through the sample.
- 2. by measuring the X-ray fluorescence.
- 3. by measuring the electron yield.



EXAFS – What information can it provide ?

EXAFS spectroscopy provides:

- 1. Accurate inter-atomic distances to nearby atoms.
- 2. An estimate of the size (atomic no.) of a nearby atom.
- 3. An estimate of the number of similarly coordinated nearby atoms.

What is EXAFS ?

EXAFS – Extended X-ray Absorption Fine Structure

The oscillatory X-ray absorption above an edge.



EXAFS – Basic Physics

Photo-electron DeBroglie wave.



Schematics diagrams of final state wave functions.

EXAFS Data reduction **Extracting the EXAFS** 1.4 1.2 raw data Absorbance 9.0 pre-edge polynomial $\mu_{\rm S}$ spline 0.4 0.2 pre-edge subtracted data 📙 8100 8300 8700 8900 9100

• EXAFS oscillations χ are extracted from the absorbance μ by successive subtraction of a pre-edge polynomial, fitted through the pre-edge region, and then a spline function fitted through the EXAFS region.

8500

X-ray Energy (eV)

• The abscissa is converted from an incident X-ray energy scale to reciprocal Ångströms.



• The EXAFS, χ , which is the oscillatory part of the absorption coefficient, is given by $\chi = (\mu - \mu_S)/\mu_0$ and the EXAFS oscillations are plotted as a function of the wavevector k, and (typically) k^3 weighted.

EXAFS Data reduction

The EXAFS Fourier transform



- Important for a first look at the data gives an approximate radial structure.
- The EXAFS Fourier transform is calculated from the EXAFS by: $\rho(R) = \frac{1}{4\pi^{1/2}} \int_{k_{min}}^{k_{max}} \chi(k) k^3 e^{i2kR} dk$
- Often phase-corrected transforms are calculated: $\rho(\mathbf{R}) = \frac{1}{4\pi^{1/2}} \int_{\mathbf{k}...\mathbf{k}}^{\mathbf{k}_{max}} \chi(\mathbf{k}) k^3 e^{i2\mathbf{k}\mathbf{R} + i\phi(\mathbf{k})} d\mathbf{k}$

• The power spectrum (transform magnitude) is calculated from: $|\rho(R)| = \left\{ \Re[\rho(R)]^2 + \Im[\rho(R)]^2 \right\}^{1/2}$

19

The EXAFS Fourier transform



The EXAFS Fourier transform of the tetraphenylarsonium cation, phase-corrected for As–C backscattering.

The peaks in the transform correspond to inter-atomic distances.



EXAFS Data reduction

EXAFS Curve Fitting Analysis



Best fit analysis with 4 Ni-S at 2.292 (3) Å, σ^2 = 0.00270 (12) Å²

- A combination of differences in phase and amplitude functions makes determination of scatterer type, coordination number and distance possible.
- EXAFS gives very accurate interatomic distances (typically better than ± 0.02 Å).

• EXAFS gives less accurate coordination numbers and Debye-Waller factors ($ca. \pm 25$ %).



General parameters:		Chemical sensitivity:		Structural parameters:	
χ(k)	The EXAFS function	¢(k, R)	Phase function	Ν	Coordination number
k	Photoelectron wavevector	A(k, R)	Amplitude function	R	Interatomic distance
Σ	Sum over all absorber-backscatterer shells <i>i</i> ,	λ(k, R)	Photoelectron mean free path function	σ²	Debye-Waller factor

EXAFS Amplitude Components



23





Chemical Sensitivity from Phase and Amplitude Functions

Backscatterers of different Z (e.g. O, Si, Fe) can be easily distinguished Backscatterers of similar Z (e.g. N and O) cannot



The structure in the phase and amplitude functions is due to the interaction of the photoelectron with the electron clouds of both the absorber and backscatterer atoms, and hence is element-specific.

Structural Parameters in EXAFS



The Debye-Waller Factor

• The Debye-Waller factor σ^2 is the mean-square displacement from the mean separation R_0 of the backscatterer B relative to absorber A in the direction of the A-B vector.

 The Debye-Waller factor can be expressed as the sum of a vibrational contribution and a static contribution. The magnitudes of the two components can be deduced by means of temperaturedependent EXAFS measurements.

 The static contribution is due to a structural distribution of mean interatomic distances, and can be expressed as the mean square distribution σ^{2}_{stat} .

 The vibrational contribution is temperature dependent. For diatomic harmonic systems, σ^2_{vib} can be approximately given by the equation shown, and can be used as a gualitative measure of bond strength for closely related systems. μ - reduced mass

 Reduced thermal vibrations at low temperatures give rise to increased EXAFS amplitudes, and therefore to improved signal to noise and greater availability of structural information.

- T temperature
- *v* vibrational frequency
- k_B Boltzmann' s constant



What EXAFS Curve Fitting can and cannot do.

R – Interatomic distance

Accuracy – \pm 0.02 Å, *i.e.* well-defined

N – Coordination number

Accuracy – \pm 25 %, *i.e.* less well-defined

σ² – Debye-Waller factor

Typical range: $0.0015 \le \sigma^2 \le 0.0080 \text{ Å}^2$



Effect of ΔE_0 =10 eV.

 ΔE_o – refinable energy offset for k = 0 threshold

Correlations:

N correlates strongly with σ^2 , R correlates with E_0 .

Resolution: two shells, same backscatterer type. $\Delta R \approx \pi / 2k$

Distinguishing different backscatterer types.

elements with similar atomic number cannot be distinguished (*e.g.* P and S, Si and AI).

EXAFS Resolution



two shells, same backscatterer type, $\Delta R \approx \pi / 2k = 0.103 \text{ Å}$

Detection of X-ray Absorption Spectroscopy

Detection method	Concentration range	Comments
Transmittance	High concentration (typically > 2 wt. %)	Easiest detection method; least prone to distortions
Fluorescence (non-dispersive)	Medium to low concentrations (> 5 mM)	Thickness effects occur for too high a concentration
Fluorescence (energy dispersive)	Low concentrations (> 1 ppm, 0.1 mM)	Detector linearity and countrates can be a problem
Electron yield	High to medium concentrations Low Z absorbers	"Surface sensitive" (typically probes 20-100Å)

X-ray absorption spectroscopy – experimental setup.



Setup includes a liquid He cryostat and 30 element Ge detector array.



Protein sample showing image of beam (X-ray induced color centers).

Why use Low Temperatures?

• Low temperatures help to prevent radiation damage to the sample.

Low temperature sample holder containing an aqueous solution of a metalloprotein (immersed in a bath of liquid nitrogen) after a four hour exposure to the Xray beam at a temperature of 10K. The image of the Xray beam can be clearly seen on the sample, the coloration being due to hydrated electrons trapped in the ice matrix.

The color vanishes after *ca.* 10 min. at 77K.



Why use Low Temperatures?

• The EXAFS is more intense due to freezing out of atomic vibrations.

e.g. Fourier transform of Sr Kedge EXAFS of SrCo_{0.8}Fe_{0.2}O_{2.5}



Monochromators

• For XAS experiments we need to be able to scan through a range of energies (really choose a bunch of single energies, very close to each other)

• this is commonly achieved using diffraction off two crystals – a "double crystal monochromator"

 $n\lambda = 2d \cdot \sin \theta$

- *d* is spacing between crystal planes, λ is wavelength, n is an integer
- "white" light in a narrow band of wavelengths out
- harmonics and glitches will appear





Diffraction Monochromators

 $n\lambda = 2d \cdot \sin \theta$

- *d* is spacing between crystal planes, λ is wavelength, n is an integer
- "white" light in a narrow band of wavelengths out



Choice of monochromator crystals

• Monochromatorcrystal material must have excellent stability to X-rays, thermalloading; high reflectivity, *etc.*

Silicon is most widely used material

- Choose different cuts based on:
 - Working energy range:

Crystal cut	d(Å)	E _{min} (eV)	E _{max} (eV)
Si(111)	3.1356	1977	~18500
Si(220)	1.9201	3228	~29000
Si(400)	1.3577	4556	~42000

• Energy resolutionSi(111) < Si(220) < Si(400)

Note that vertical slits before monochromator also control resolution

- Flux: Si(111) > Si(220) > Si(400)
- Crystal glitches

Choice of monochromator crystals



Energy Calibration

Absolute energy determination is very difficult. XAS is normally done in a relative energy sense against an arbitrary agreed standard.



Typically calibrate on lowest energy inflection of elemental foil of correct thickness.

Data modeling or "curve fitting"

Fitting the EXAFS and the "goodness of fit" parameter

• first we need to guess at what backscatterers are present and calculate phase and amplitude functions for these

• then we make an initial guess at the parameters in the EXAFS eqn i.e. for each scattering path, N, R, σ^2 , ΔE_0 (same for all paths) and calculate

$$R_{\text{EXAFS}} = \sqrt{\int \left[\chi_{\text{expt}}(k) - \chi_{\text{calc}}(k)\right]^2 \, \mathrm{d}k / \int \chi_{\text{expt}}(k)^2 \, \mathrm{d}k}$$

• Because the experimental data is actually numeric (i.e. pointwise) and because it is common to k³-weight the data, this reduces to

$$R_{\rm EXAFS} = \sqrt{\sum k^6 (\chi_{\rm expt} - \chi_{\rm calc})^2 / \sum k^6 (\chi_{\rm expt})^2}$$

• we (i.e. the computer program) then makes small adjustments to some or all of the parameters and determines if R_{EXAFS} has decreased or not, if yes then keep going, if not then make opposite adjustments

- continue until the change in R_{EXAFS} is smaller than some arbitrary amount
- i.e. this is an iterative minimisation!

Comparing models

- This is fine for chemical species whose compositions we are sure about and will provide N, R, etc
- However, in many cases we may not necessarily know the number and identity of all ligands
- In these cases a number of potential theoretical model species can be fitted to the experimental data and their similarity to the reality of the actual sample assessed by comparison of R_{EXAFS} (the smaller the better).
- In this way EXAFS can provide more than just N, R etc it can also identify ligands that are present
- Caution is needed however increasing the number of parameters will reduce R_{EXAFS} without necessarily improving the fit.

The amount of data vs. the number of fitted parameters – "determination"

• The actual number of data points is limited in EXAFS – this means that we can only fit a parameter set of a certain size

• For the structural information we derive from the fitting process to be statistically significant (i.e. trustworthy) the number of *independent* experimental data points (N_i) must be greater than the number of fitted variables (p) in the model

• For EXAFS $N_i = 2(\Delta R.\Delta k)/\pi$

• If $N_i > p$ then the fit is *overdetermined* (this is good)

• so if $\Delta R = 3$ and $\Delta k = 12$ then we can determine ~ 23 independent parameters – must do S₀2 and ΔE_0 which leaves 21, so we can just get away with N, R and σ^2 for six distinct ligands in a six coordinate complex but NO multiple scattering

• (the estimate of N_i is a BIG guess so best to have very overdetermined models)

A solution $N \equiv N$ cleavage reaction.

- Laplaza and Cummins have reported a remarkable N=N cleavage reaction that proceeds via the formation of an N₂-containing intermediate which is stable at low temperatures.
- We determined the core structure using EXAFS spectroscopy.



Laplaza, C.E.; Cummins, C.C. 1995, Science, 268, 861-863.

Purple intermediate – Mo K-edge EXAFS



Solid lines experimental data, broken lines best fit (see below).

Purple intermediate – Mo K-edge EXAFS Fourier transforms



46



Multiple scattering makes the EXAFS of the Mo–N=N–Mo compound sensitive to geometry.

Mo–N=N–Mo EXAFS Geometry sensitivity



Postulated structure of purple intermediate.



- Core structure determined from EXAFS.
- Remainder of molecule from computational chemistry.

X-ray absorption near-edge structure (XANES)

X-ray Absorption Spectroscopy – Basic Physics



(μ here is the absorption coefficient from Beer's Law, i.e. A = μ c I)





X-ray absorption near-edge spectra



- as the oxidation state of the absorbing atom increases the energy position of the absorption edge increases
- this is due to the fact that the frontier orbitals are more shielded from the nucleus than the 1s
- the energy of both orbitals decreases but 1s goes further
- hence XANES is sensitive to oxidation state of the absorbing atom
- also, the excited electron probes the valence orbitals so the XANES is very sensitive to coordination environment

X-ray absorption near-edge spectra

- Near-edge spectra are sensitive to electronic structure.
- They can be used to "fingerprint" the chemical species present.
- Complex mixtures can be analyzed by fitting to a linear combination of model spectra.



XANES monitoring of photodamage

- Successive scans on a Cu compound indicate that exposure to the x-ray beam is modifying the sample!
- In-built monitoring
- In this case the reduction in the edge energy with time indicates photoreduction



XANES sensitivity to chemical form

• Could accurately determine pH for sample containing arsenate or arsenite



XANES sensitivity continued



Levina A, Harris HH and Lay PA, J. Am. Chem. Soc, 2007, 129, 1065-1075

XANES analysis of mixtures

Percentage compositions of mixtures of compounds of one element can be determined by fitting a linear combination of model compound XANES to the XANES of the mixture

• Need good model compound spectra – i.e. good energy calibration and no distortion

• need spectra for all components!

• error of $\sim \pm 5\%$ -depending on spectral noise



Selenite metabolism – A549 human lung cancer



Selenite metabolism – A549 human lung cancer

Debye-Waller interatomic coordination fit $-\Delta E_0$ distance factor treatment (µM) scatterer number (N) (eV) error (R, Å) $(\sigma^2, \text{\AA}^2)$ S 1.3 2.195(5) 0.0023(3) 9(1) 5 0.30 Se 0.7 2.370(4) 0.0017(1)1.2 Transform Magnitude 2 $\chi(k) \ge k^3$ 0.8 0.6 -2 0. -4 0.2 -6 13 5 9 11 0 k (Å⁻¹) $R + \Delta (Å)$

5 μ M selenite treatment – 24 h

Weekley, C. M. et al. (2011). J. Am. Chem. Soc., 133, 18272-9